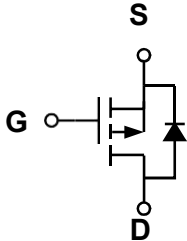
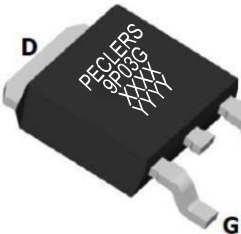
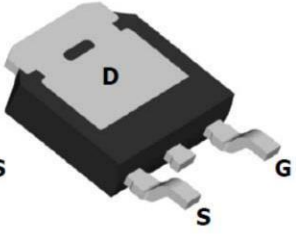



30V P-Channel Enhancement Mode MOSFET

<p>Schematic diagram</p>  <p>Marking and pin assignment</p> <div style="display: flex; justify-content: space-around;"> <div style="text-align: center;"> <p>Top View</p>  </div> <div style="text-align: center;"> <p>Bottom View</p>  </div> </div> <p>XXXX—Date Code YYYY—Quality Code</p>	<p>Description</p> <p>The PECN9P03G uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.</p> <p>General Features</p> <ul style="list-style-type: none"> ◆ $V_{DS} = -30V$ $I_D = -25A$ $R_{DS(ON)}(Typ.) = 14.5m\Omega$ @ $V_{GS} = -10V$ $R_{DS(ON)}(Typ.) = 19.5m\Omega$ @ $V_{GS} = -4.5V$ High power and current handling capability ◆ Lead free product is acquired ◆ Surface mount package <p>Application</p> <ul style="list-style-type: none"> ◆ Load switch <p>Package</p> <ul style="list-style-type: none"> ◆ TO-252-2L <div style="text-align: right; margin-top: 10px;">  </div>
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Ordering Information

Part Number	Storage Temperature	Package	Devices Per Reel
PECN9P03G	-55°C to +150°C	TO-252-2L	2500

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

parameter	symbol	limit	unit
Drain-source voltage	V_{DS}	-30	V
Gate-source voltage	V_{GS}	±20	V
Continuous Drain Current	I_D	TC=25°C	-25
		TC=100°C	-16
Pulsed Drain Current	I_{DP}	-100	A
Avalanche Current	I_{AS}	-15	A
Avalanche energy(L=0.5mH)	EAS	170	mJ
Maximum power dissipation	P_D	TC=25°C	85
		TC=100°C	44
Operating junction Temperature range	T_j	-55—150	°C

Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-30	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=-30V, V_{GS}=0V$	-	-	1	μA
		$T_J=85^\circ C$	-	-	30	
Gate Leakage Current	I_{GSS}	$V_{DS}=0V, V_{GS}=\pm 20V$	-	-	± 100	nA
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.2	-1.6	-2.5	V
Drain-source on-state resistance ¹	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-10A$	-	14.5	20	m Ω
		$V_{GS}=-4.5V, I_D=-7A$	-	19.5	25	
On Status Drain Current	$I_{D(ON)}$	$V_{DS}=-15V, V_{GS}=-10V$	25	-	-	A
Diode Characteristics						
Diode Forward Voltage ¹	V_{SD}	$I_{SD}=-25A, V_{GS}=0V$	-	-0.8	-1.3	V
Diode Continuous Forward Current	I_S		-	-25	-	A
Reverse Recovery Time	t_{rr}	$I_F=-15A,$	-	24	-	ns
Reverse Recovery Charge	Q_{rr}	$di/dt=-100A/\mu s$	-	16	-	nC
Dynamic Characteristics²						
Gate Resistance	R_G	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	-	0.65	-	Ω
Input capacitance	C_{ISS}	$V_{GS}=0V, V_{DS}=-15V$ $f=1.0MHz$	-	1360	-	pF
Output capacitance	C_{OSS}		-	250	-	
Reverse transfer capacitance	C_{RSS}		-	210	-	
Turn-on delay time	$t_{D(ON)}$	$V_{GS}=-10V, V_{DD}=-30V,$ $R_L=3\Omega, I_D=1A, R_G=2.5\Omega$	-	9	-	ns
Turn-on Rise time	t_r		-	10	-	
Turn-off delay time	$t_{D(OFF)}$		-	50	-	
Turn-off Fall time	t_f		-	20	-	
Total gate charge	Q_g	$V_{GS}=-10V, I_D=-15A$ $V_{DS}=-15V$	-	31	-	nC
Gate-source charge	Q_{gs}		-	3	-	
Gate-drain charge	Q_{gd}		-	9	-	

Note: 1: Pulse test; pulse width $\leq 300ns$, duty cycle $\leq 2\%$.

2: Guaranteed by design, not subject to production testing.

Thermal Characteristics

Parameter	Symbol	Typical	Unit
Thermal Resistance-Junction to Case	$R_{\theta jc}$	1.7	$^\circ C/W$
Thermal Resistance junction-to ambient	$R_{\theta ja}$	62.5	

Typical Performance Characteristics

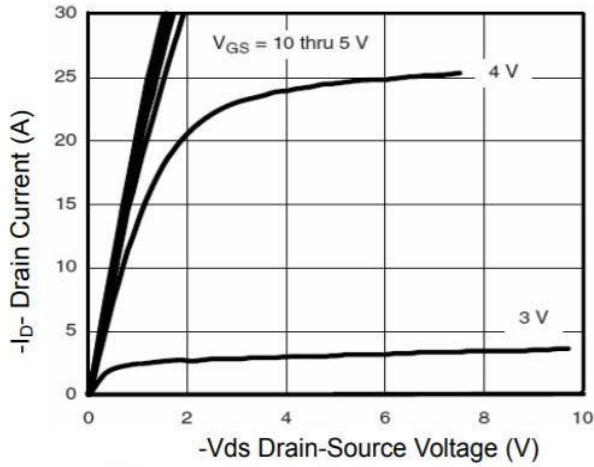


Figure 1 Output Characteristics

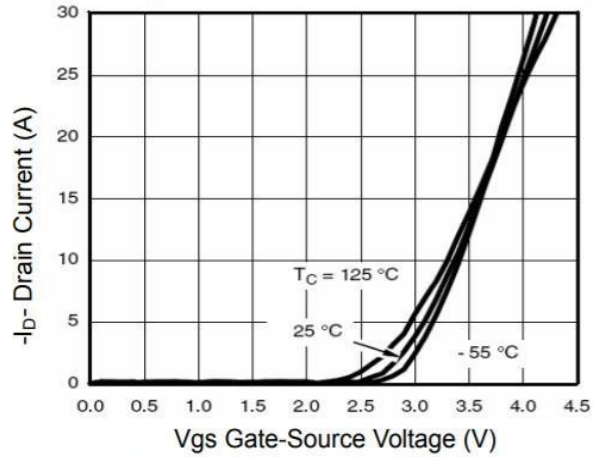


Figure 2 Transfer Characteristics

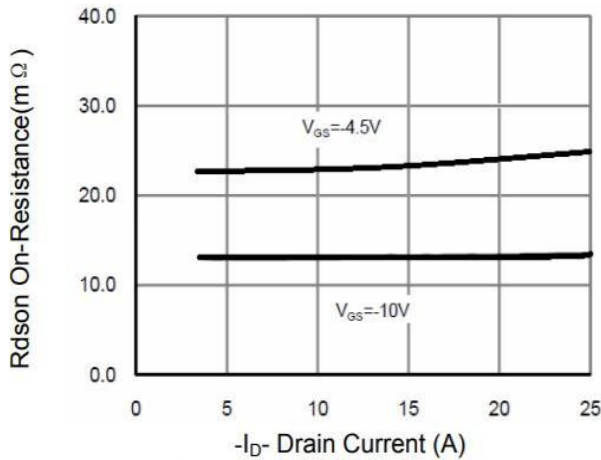


Figure 3 Rdson- Drain Current

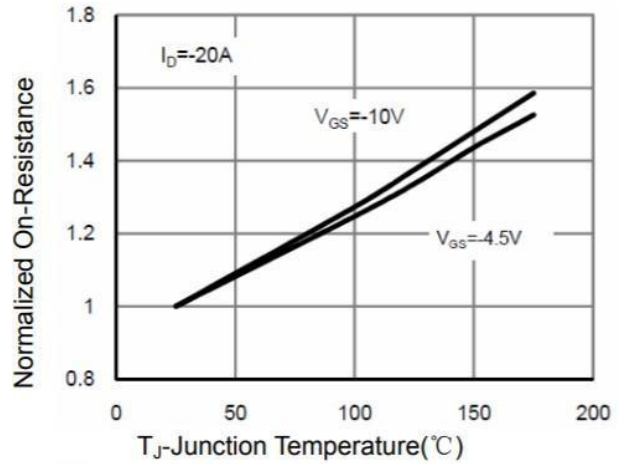


Figure 4 Rdson-Junction Temperature

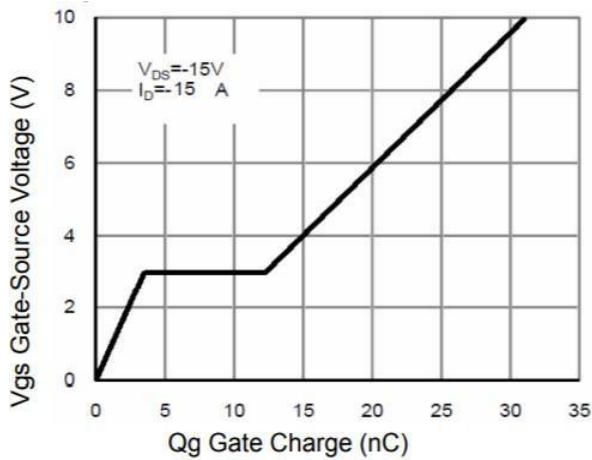


Figure 5 Gate Charge

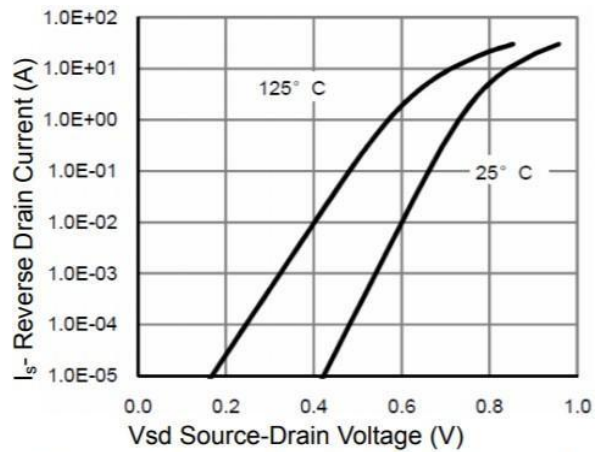


Figure 6 Source- Drain Diode Forward

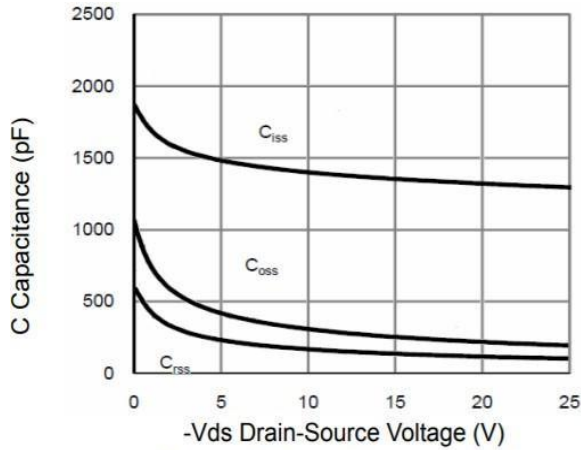


Figure 7 Capacitance vs Vds

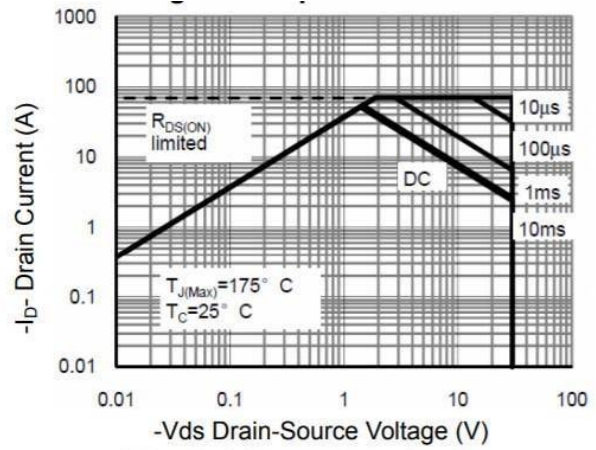


Figure 8 Safe Operation Area

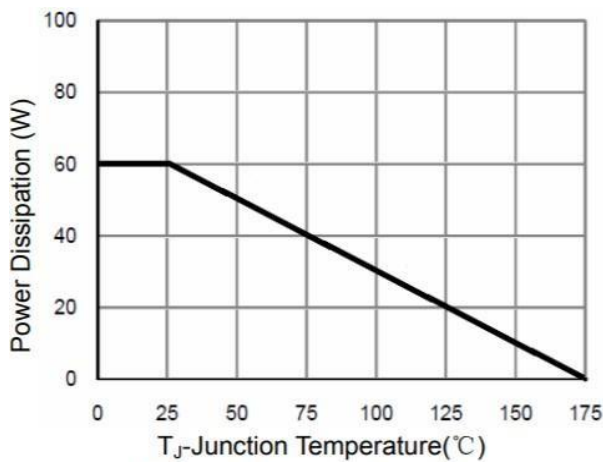


Figure 9 Power De-rating

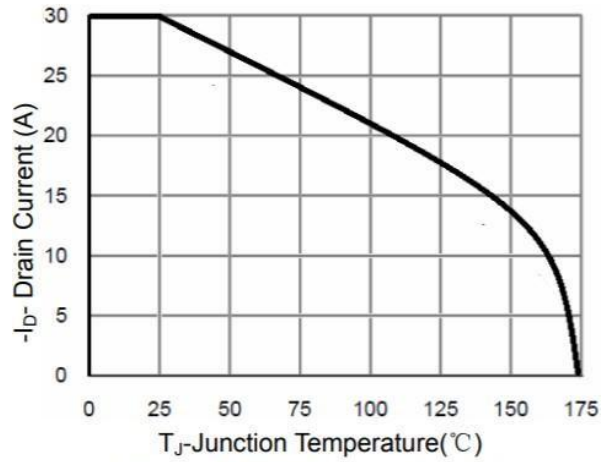


Figure 10 ID Current Derating

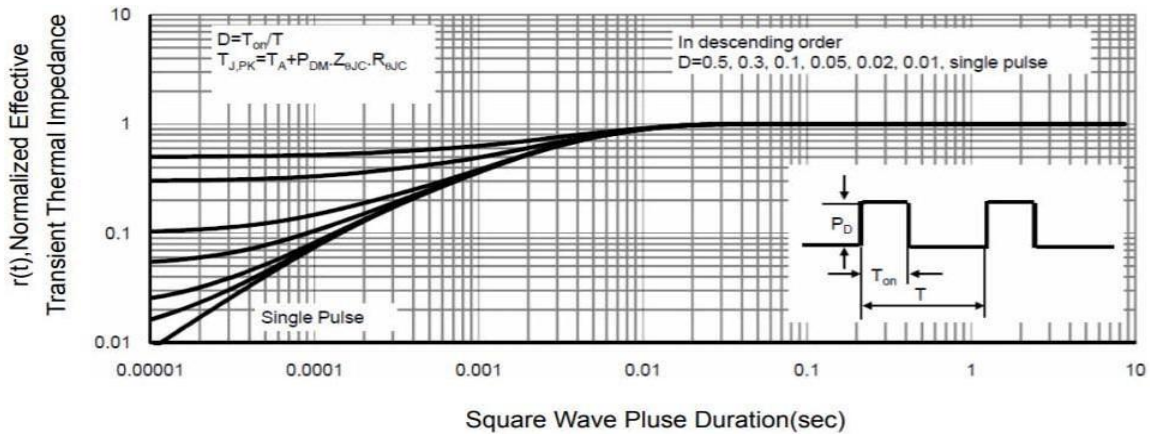


Figure 11 Normalized Maximum Transient Thermal Impedance

Figure A: Gate Charge Test Circuit & Waveforms

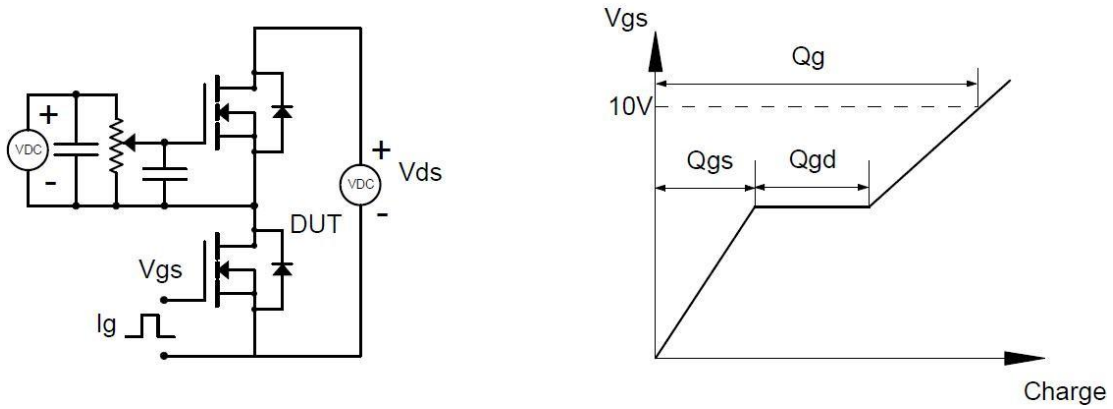


Figure B: Resistive Switching Test Circuit & Waveforms

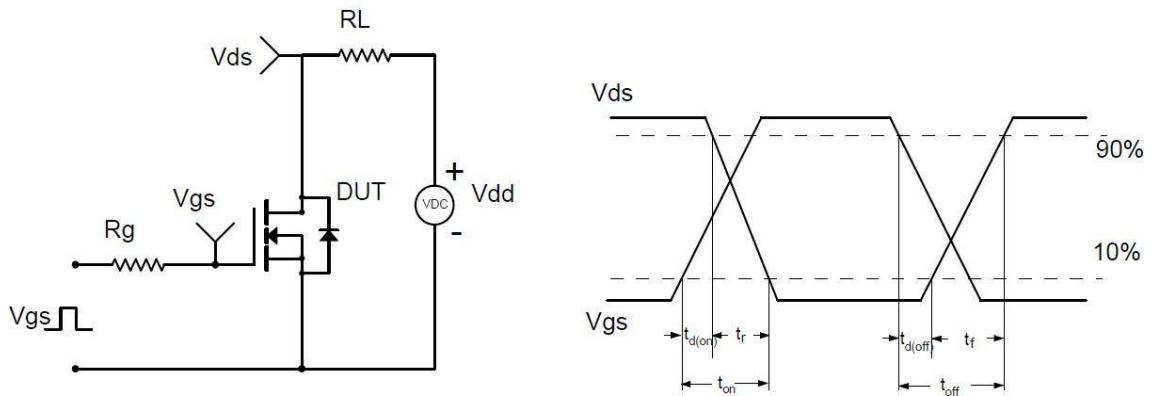


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

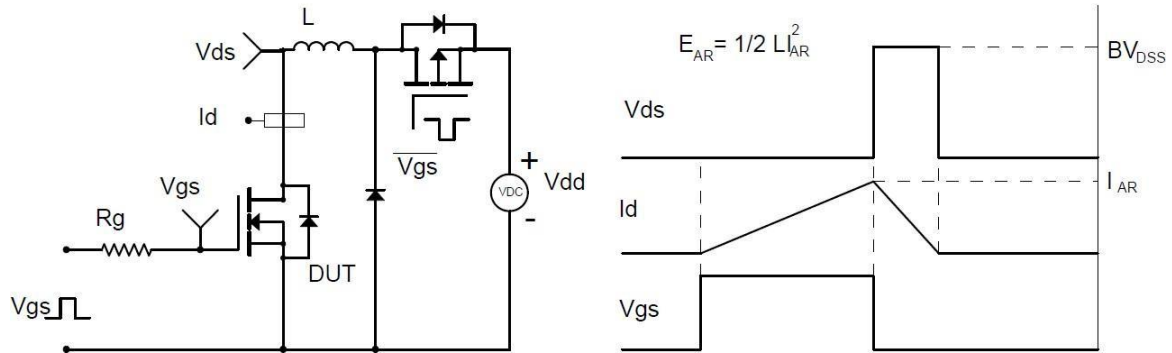
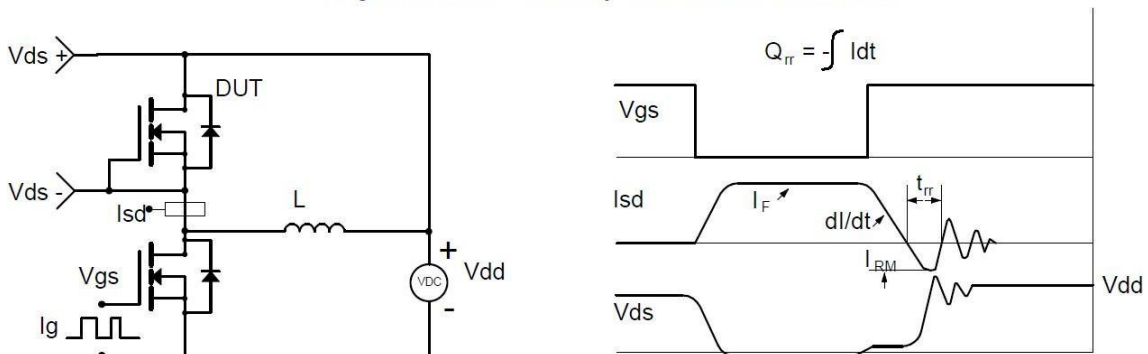
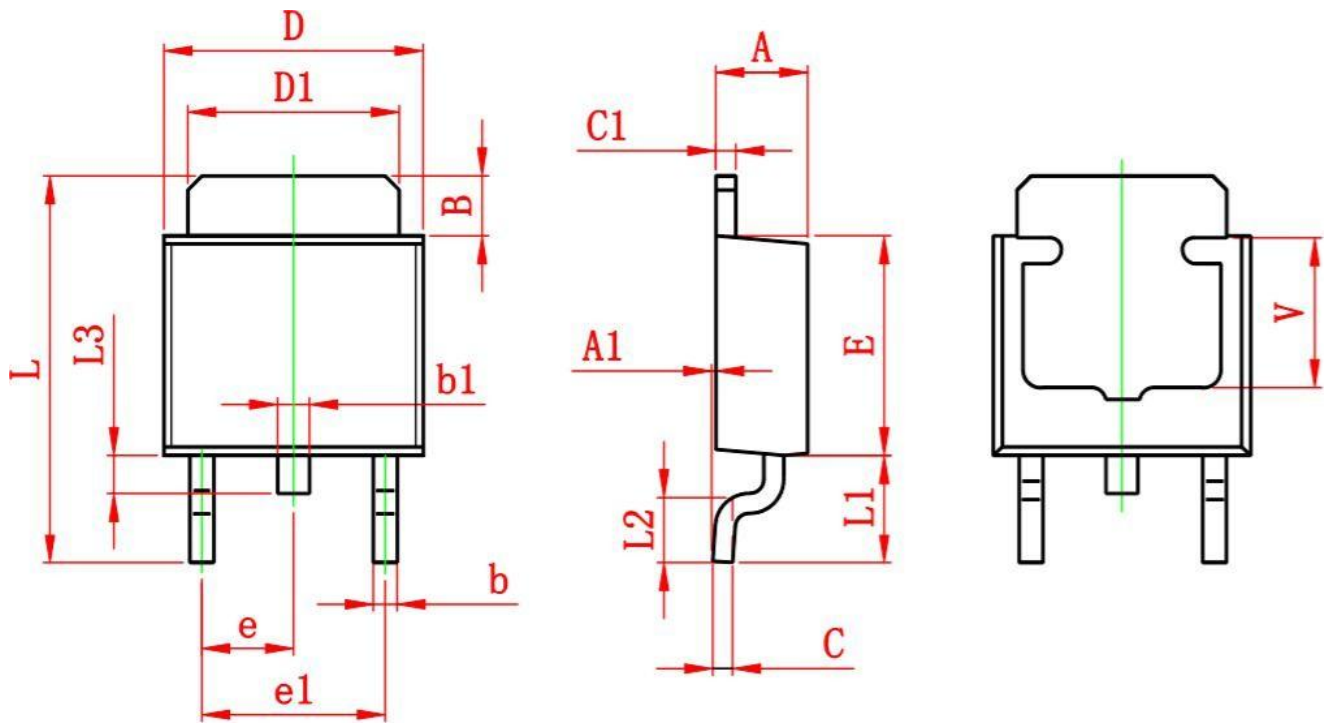


Figure D: Diode Recovery Test Circuit & Waveforms



Package Information

- TO-252-2L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
B	1.350	1.650	0.053	0.065
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
c	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	5.700	0.213	0.224
e	2.300 TYP.		0.091 TYP.	
e1	4.500	4.700	0.177	0.185
L	9.500	9.900	0.374	0.390
L1	2.550	2.900	0.100	0.114
L2	1.400	1.780	0.055	0.070
L3	0.600	0.900	0.024	0.035
V	3.800 REF.		0.150 REF.	